

KWS5

RELIABILITY DATA

信頼性データ

No. RD-07T-239B		
承認	査閲	担当
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※信頼性試験は代表データであり、この値は実力値とお考え願います。

※本データに掲載しております内蔵部品の名称は、本製品を開発した当初のものです。
これらは改善等の為に変更されている可能性もありますが、ご了承下さい。

The following data are typical values and the data to be considered as ability values.
The built-in components names on this data are the things the time of Development.
Please understand that it may be changed for an improvement etc.

1. MTBF 計算値 CALCULATED VALUES OF MTBF

MODEL : KWS5

(1) 算出方法 Part count reliability projection

(社)日本電子機械工業会 直流安定化電源(スイッチング方式)委員会の部品点数法で算出されています。

それぞれの部品ごとに、部品故障率 λ_g が与えられ、各々の点数によって決定されます。 λ_g は、MIL-HDBK-217Dに準じて定められています。

Calculated based on part count reliability projection by the Technical Committee on Stabilized Power Supplies of EIAJ.

Fixed failure rate λ_g is given to each individual part and MTBF is determined by the count of each part.

λ_g is determined based on MIL-HDBK-217D.

<算出式>

$$MTBF = \frac{1}{\lambda_{equip}} = \frac{1}{\sum_{i=1}^n N_i (\lambda_g)_i} \times 10^6 \text{ 時間 (Hours)}$$

λ_{equip} : 全機器故障率 (故障数／ 10^6 時間)

Total Equipment Failure Rate (Failure／ 10^6 Hour)

λ_g : i番目の同属部品に対する故障率 (故障数／ 10^6 時間)

Generic Failure Rate for The ith Generic Part

N_i : i番目の同属部品の個数

Quantity of ith Generic Part

n : 異なった同属部品のカテゴリーの数

Number of Different Generic Part Categories

(2) MTBF 値

$$MTBF = \frac{1 \times 10^6}{4.7817} \approx 209,130 \text{ 時間 (Hours)}$$

2. 部品ディレーティング COMPONENT DERATING

MODEL : KWS5-5



(1) 算出方法 Calculating method

(a) 測定条件 Condition

・入力 : 100VAC 　・出力 : 5V1A (100%)

Input Output

・周囲温度 : 50°C 　・取付方法 : 標準取付(A)

Ambient temperature Mounting Method : Standard Mounting Method (A)

(b) 半導体 Semiconductors

周囲温度, 消費電力, 熱抵抗より使用状態の接合点温度を求め最大定格, 接合点温度との比較を求めました。

Compared with maximum junction temperature and actual one which is calculated based on ambient temperature, power dissipation and thermal impedance.

(c) IC, 抵抗, コンデンサー等 IC, Resistors, Capacitors, etc.

周囲温度, 使用状態, 消費電力など, 個々の値は設計基準内に入っています。

Ambient temperature, operating condition, power dissipation and so on are within derating criteria.

(d) 熱抵抗算出方法 Calculating method of thermal impedance

$$\theta_{j-c} = \frac{T_{j(max)} - T_c}{P_{c(max)}} \quad \theta_{j-a} = \frac{T_{j(max)} - T_a}{P_{c(max)}}$$

T_c : ディレーティングの始まるケース温度 一般に25°C

Case Temperature at Start Point of Derating ; 25°C in General

T_a : ディレーティングの始まる周囲温度 一般に25°C

Ambient Temperature at Start Point of Derating ; 25°C in General

$P_{c(max)}$: 最大コレクタ損失

Maximum Collector Dissipation

$T_{j(max)}$: 最大接合点温度

Maximum Junction Temperature

θ_{j-c} : 接合点からケースまでの熱抵抗

Thermal Impedance between Junction and Case

θ_{j-a} : 接合点から周囲までの熱抵抗

Thermal Impedance between Junction and Air

SEMICONDUCTOR DERATING

DWG. NO.

PA766-56-03

DATE : 21-MAY-1992

MODEL : KWS5-5

VIN = AC 100V

LOAD = 100%

Ta = 50°C

Q1 2SK1533-4100 SHINDENGEN	Tchmax = 150 °C	$\Theta_{ch-c} = 12.5 \text{ °C/W}$	Pd(max) = 10.0 W
	Pd = 0.570 W	$\Delta T_c = 36.0 \text{ °C}$	Tc = 86.0 °C
	$T_{ch} = T_c + (\Theta_{ch-c}) * P_d = 93.13 \text{ °C}$		
	D.F. = 62.1 %		
A1 UC2842ADW UNITRODE	Tjmax = 150 °C	$\Theta_{j-c} = 70.0 \text{ °C/W}$	Pd(max) = 0.725 W
	Pd = 0.299 W	$\Delta T_c = 30.2 \text{ °C}$	Tc = 80.2 °C
	$T_j = T_c + (\Theta_{j-c}) * P_d = 97.23 \text{ °C}$		
	D.F. = 64.48 %		
A2 HA17431FPA HITACHI	Tjmax = 125 °C	$\Theta_{j-c} = 259.74 \text{ °C/W}$	Pd(max) = 0.385 W
	Pd = 0.12 mW	$\Delta T_c = 26.3 \text{ °C}$	Tc = 76.3 °C
	$T_j = T_c + (\Theta_{j-c}) * P_d = 76.33 \text{ °C}$		
	D.F. = 61.1 %		
PC1 (LED) TLP121GR TOSHIBA	Tjmax = 125 °C	$\Theta_{j-c} = --- \text{ °C/W}$	Pd(max) = 50 mW
	If = 0.07 mA	$\Delta T_c = 22.7 \text{ °C}$	Tc = 72.7 °C
	Allowable If(max) = 30 mA (at Tc = 72.7°C)		
	D.F. = 0.18 %		
PC1 (TRANSISTOR) TLP121GR TOSHIBA	Tjmax = 125 °C	$\Theta_{j-c} = 400 \text{ °C/W}$	Pd(max) = 150 mW
	Pd = 0.15 mW	$\Delta T_c = 22.7 \text{ °C}$	Tc = 72.7 °C
	$T_j = T_c + (\Theta_{j-c}) * P_d = 72.76 \text{ °C}$		
	D.F. = 58.21 %		
D1 S1WB(A)60B SHINDENGEN	Tjmax = 150 °C	$\Theta_{j-l} = 10.0 \text{ °C/W}$	Pd(max) = 12.5 W
	Pd = 0.27 W	$\Delta T(\text{lead}) = 21.5 \text{ °C}$	T(lead) = 71.5 °C
	$T_j = T_l + (\Theta_{j-l}) * P_d = 74.2 \text{ °C}$		
	D.F. = 49.5 %		
D2 1SS184TE85L TOSHIBA	Tjmax = 125 °C	$\Theta_{j-l} = 100 \text{ °C/W}$	Pd(max) = 150 mW
	Pd = 17.0 mW	$\Delta T(\text{lead}) = 24.2 \text{ °C}$	T(lead) = 74.2 °C
	$T_j = T_l + (\Theta_{j-l}) * P_d = 75.9 \text{ °C}$		
	D.F. = 60.72 %		

SEMICONDUCTOR DERATING

DWG. NO. PA766-56-04

DATE : 21 - MAY - 1992

MODEL : KWS5-5

dT TEMPERATURE RISE

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DWG. NO.

PA766-66-02

MODEL : KWS5-5

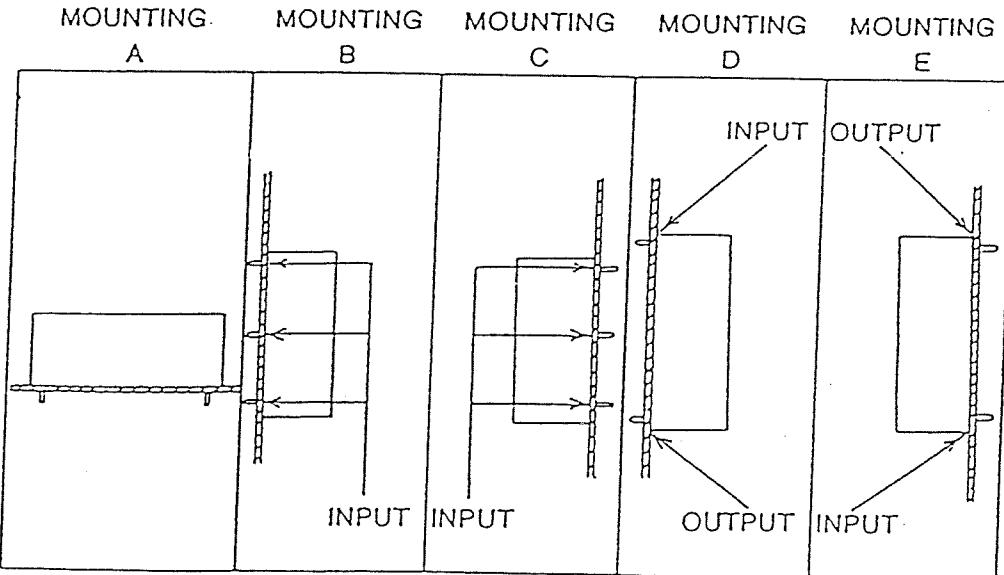
DATE : 15-MAY-1992

INPUT VOLTAGE = 100VAC

Ta = 50°C		dT TEMPERATURE RISE (°C)				
OUTPUT DERATING (%)		100%	100%	100%	100%	100%
SYMBOL	PARTS NAME	MOUNTING A	MOUNTING B	MOUNTING C	MOUNTING D	MOUNTING E
Q1	MOSFET	36.0	35.1	35.1	35.9	32.6
A1	PWM IC	30.2	29.9	29.0	30.6	26.8
D5	SBD	38.2	36.6	38.2	36.8	35.8
T1	X'TMER	31.4	30.3	31.2	30.8	29.0
C5	E.CAP	24.0	24.2	23.0	23.9	21.4
C16	OS CAP.	27.8	27.3	27.0	27.0	26.3

INPUT VOLTAGE = 200VAC

Ta = 50°C		dT TEMPERATURE RISE (°C)				
OUTPUT DERATING (%)		100%	100%	100%	100%	100%
SYMBOL	PARTS NAME	MOUNTING A	MOUNTING B	MOUNTING C	MOUNTING D	MOUNTING E
Q1	MOSFET	52.5	51.4	51.3	51.9	48.6
A1	PWM IC	38.7	38.2	37.0	38.8	34.6
D5	SBD	43.1	41.0	42.9	41.1	40.5
T1	X'TMER	38.4	36.9	38.1	37.2	35.7
C5	E.CAP	31.4	31.8	29.9	31.0	28.5
C16	OS CAP.	33.2	32.6	32.1	31.8	31.7



ELECTROLYTIC CAPACITOR LIFETIME VERSUS LOAD

MODEL : KWS5-5

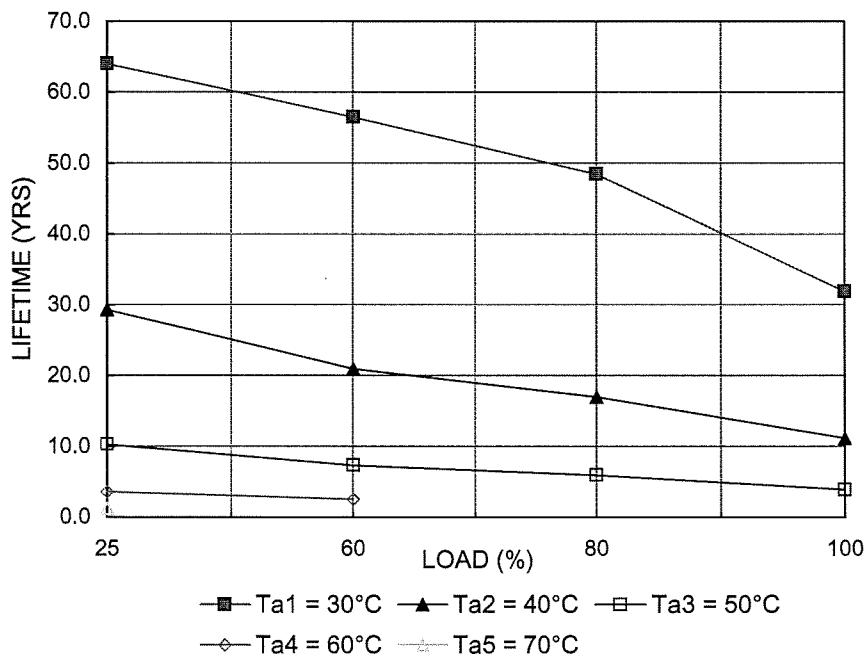
MOUNTING : A

VIN : 100VAC

DATE: SEPT 12, 2008

LOAD (%)	LIFETIME (YRS)				
	Ta = 30°C	Ta = 40°C	Ta = 50°C	Ta = 60°C	Ta = 70°C
25	64.0	29.4	10.3	3.6	1.3
60	56.5	21.0	7.4	2.6	
80	48.5	17.0	6.0		
100	31.9	11.2	3.9		

GRAPH OF ELECTROLYTIC CAPACITOR LIFETIME VS LOAD
MOUNTING A KWS5-5



計算式 FORMULA

- | | | |
|--|--------|--|
| 1. アルミ電解コンデンサ
AL. Electrolytic capacitor
$L = Lo \times 2^{(105-Tc)/10}$ | L : | 電解コンデンサ推定寿命計算値
Elec. Capacitor computed life.
(24時間連続稼動、365日)
(24 hrs per day, 365 days per year) |
| 2. OSコンデンサ
O.S capacitor
$L = Lo \times 10^{(105-Tc)/20}$ | Lo : | 電解コンデンサ保証寿命値
Guarantee life for Elec. cap. |
| | Tc : | 電解コンデンサのケース温度
Case temperature of Elec. cap. |

ELECTROLYTIC CAPACITOR LIFETIME VERSUS LOAD

MODEL : KWS5-5

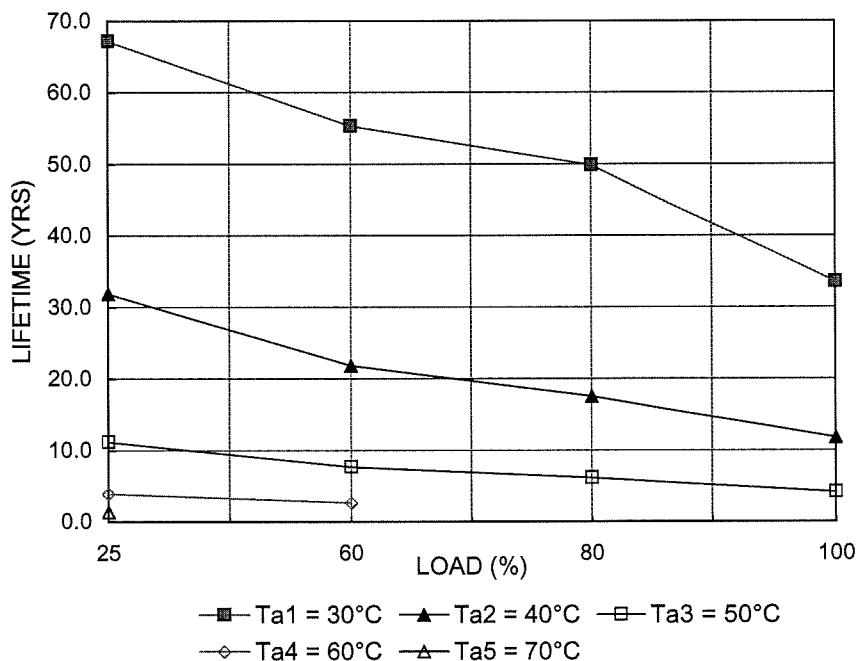
MOUNTING : B

VIN : 100VAC

DATE: SEPT 12, 2008

LOAD (%)	LIFETIME (YRS)				
	Ta = 30°C	Ta = 40°C	Ta = 50°C	Ta = 60°C	Ta = 70°C
25	67.2	31.9	11.2	3.9	1.4
60	55.4	21.9	7.7	2.7	
80	49.9	17.6	6.2		
100	33.6	11.8	4.1		

GRAPH OF ELECTROLYTIC CAPACITOR LIFETIME VS LOAD
MOUNTING B KWS5-5



計算式 FORMULA

- | | |
|--|--|
| 1. アルミ電解コンデンサ
AL. Electrolytic capacitor
$L = Lo \times 2^{(105-Tc)/10}$ | L : 電解コンデンサ推定寿命計算値
Elec. Capacitor computed life.
(24時間連続稼動、365日)
(24 hrs per day, 365 days per year) |
| 2. OSコンデンサ
O.S capacitor
$L = Lo \times 10^{(105-Tc)/20}$ | Lo : 電解コンデンサ保証寿命値
Guarantee life for Elec. cap.
Tc : 電解コンデンサのケース温度
Case temperature of Elec. cap. |

ELECTROLYTIC CAPACITOR LIFETIME VERSUS LOAD

MODEL : KWS5-5

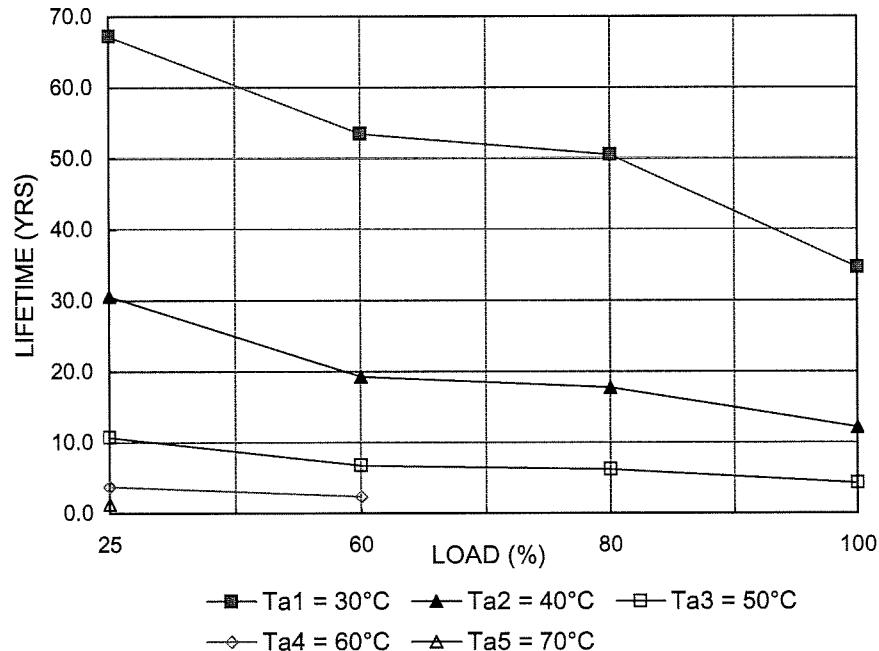
MOUNTING : C

VIN : 100VAC

DATE: SEPT 12, 2008

LOAD (%)	LIFETIME (YRS)				
	Ta = 30°C	Ta = 40°C	Ta = 50°C	Ta = 60°C	Ta = 70°C
25	67.2	30.6	10.7	3.8	1.3
60	53.5	19.3	6.8	2.4	
80	50.6	17.8	6.2		
100	34.7	12.2	4.3		

GRAPH OF ELECTROLYTIC CAPACITOR LIFETIME VS LOAD
MOUNTING C KWS5-5



計算式 FORMULA

1. アルミ電解コンデンサ
AL. Electrolytic capacitor

$$L = Lo \times 2^{(105-Tc)/10} \quad (\text{year})$$

電解コンデンサ推定寿命計算値

Elec. Capacitor computed life.

(24時間連続稼動、365日)

(24 hrs per day, 365 days per year)

2. OSコンデンサ

O.S capacitor

$$L = Lo \times 10^{(105-Tc)/20} \quad (\text{year})$$

Lo :

電解コンデンサ保証寿命値

Guarantee life for Elec. cap.

Tc :

電解コンデンサのケース温度

Case temperature of Elec. cap.

ELECTROLYTIC CAPACITOR LIFETIME VERSUS LOAD

MODEL : KWS5-5

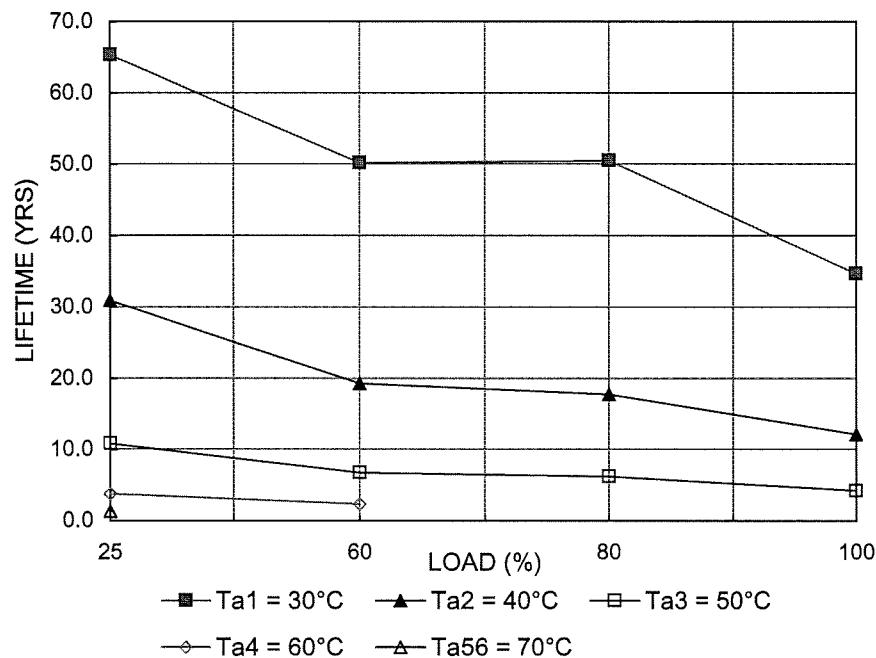
MOUNTING : D

VIN : 100VAC

DATE: SEPT 12, 2008

LOAD (%)	LIFETIME (YRS)				
	Ta = 30°C	Ta = 40°C	Ta = 50°C	Ta = 60°C	Ta = 70°C
25	65.4	30.9	10.9	3.8	1.3
60	50.2	19.3	6.8	2.4	
80	50.6	17.8	6.2		
100	34.7	12.2	4.3		

GRAPH OF ELECTROLYTIC CAPACITOR LIFETIME VS LOAD
MOUNTING D KWS5-5



計算式 FORMULA

- | | | |
|--|--------|--|
| 1. アルミ電解コンデンサ
AL. Electrolytic capacitor
$L = Lo \times 2^{(105-Tc)/10}$ | L : | 電解コンデンサ推定寿命計算値
Elec. Capacitor computed life.
(24時間連続稼動、365日)
(24 hrs per day, 365 days per year) |
| 2. OSコンデンサ
O.S capacitor
$L = Lo \times 10^{(105-Tc)/20}$ | Lo : | 電解コンデンサ保証寿命値
Guarantee life for Elec. cap. |
| | Tc : | 電解コンデンサのケース温度
Case temperature of Elec. cap. |

ELECTROLYTIC CAPACITOR LIFETIME VERSUS LOAD

MODEL : KWS5-5

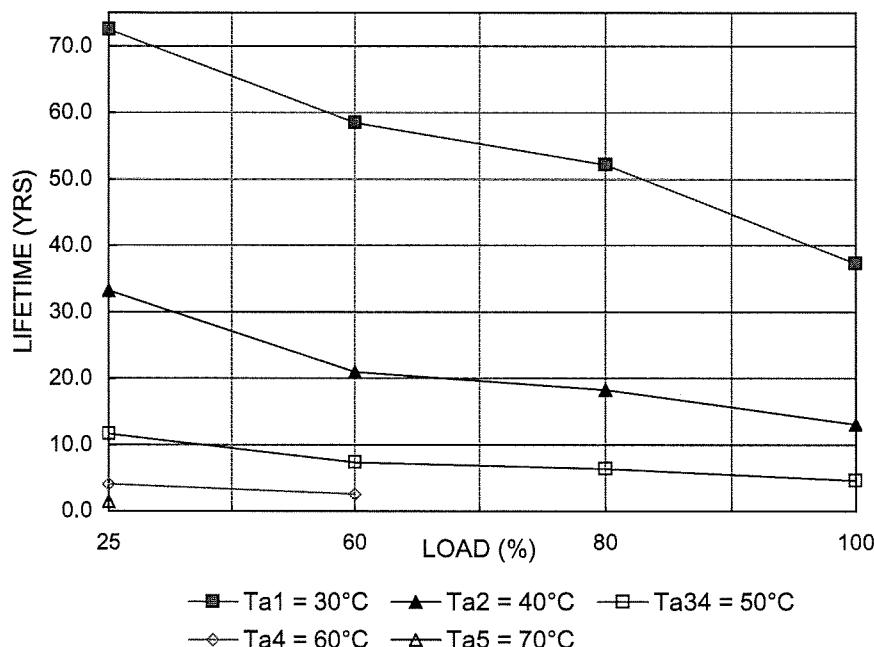
MOUNTING : E

VIN : 100VAC

DATE: SEPT 12, 2008

LOAD (%)	LIFETIME (YRS)				
	Ta = 30°C	Ta = 40°C	Ta = 50°C	Ta = 60°C	Ta = 70°C
25	72.6	33.3	11.7	4.1	1.4
60	58.5	21.0	7.4	2.6	
80	52.2	18.3	6.4		
100	37.3	13.1	4.6		

GRAPH OF ELECTROLYTIC CAPACITOR LIFETIME VS LOAD
MOUNTING E KWS5-5



計算式 FORMULA

- | | |
|--|--|
| 1. アルミ電解コンデンサ
AL. Electrolytic capacitor
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(24時間連続稼動、365日)
(24 hrs per day, 365 days per year) |
| 2. OSコンデンサ
O.S capacitor
$L = Lo \times 10^{(105-Tc)/20}$ | Lo : 電解コンデンサ保証寿命値
Guarantee life for Elec. cap.
Tc : 電解コンデンサのケース温度
Case temperature of Elec. cap. |

ELECTROLYTIC CAPACITOR LIFETIME VERSUS LOAD

MODEL : KWS5-5

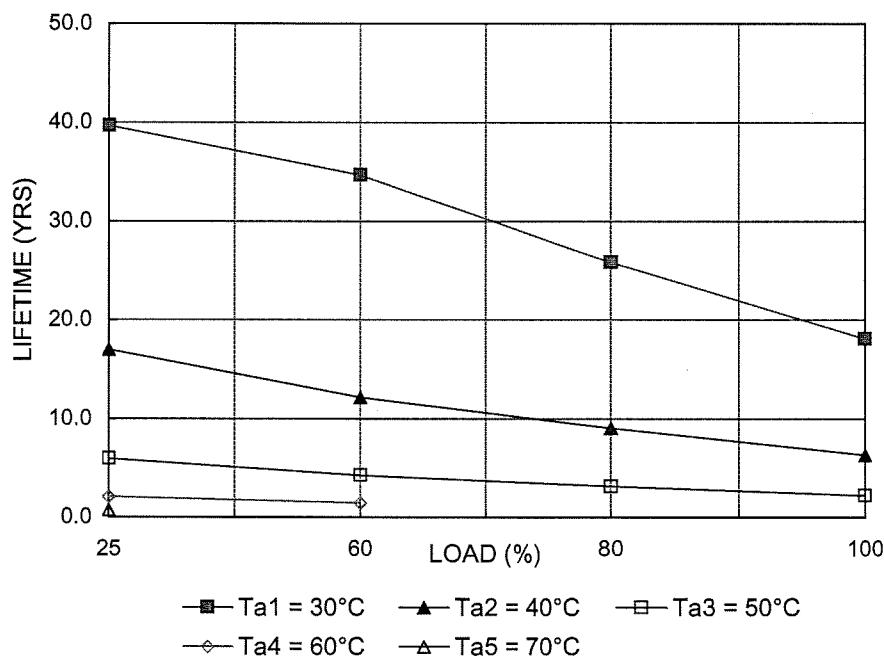
MOUNTING : A

VIN : 200VAC

DATE: SEPT 12, 2008

LOAD (%)	LIFETIME (YRS)				
	Ta = 30°C	Ta = 40°C	Ta = 50°C	Ta = 60°C	Ta = 70°C
25	39.7	17.0	6.0	2.1	0.7
60	34.7	12.2	4.3	1.5	
80	25.9	9.1	3.2		
100	18.1	6.4	2.2		

GRAPH OF ELECTROLYTIC CAPACITOR LIFETIME VS LOAD
MOUNTING A KWS5-5



計算式 FORMULA

- | | | |
|--|--------|--|
| 1. アルミ電解コンデンサ
AL. Electrolytic capacitor
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Guarantee life for Elec. cap. |
| | Tc : | 電解コンデンサのケース温度
Case temperature of Elec. cap. |

ELECTROLYTIC CAPACITOR LIFETIME VERSUS LOAD

MODEL : KWS5-5

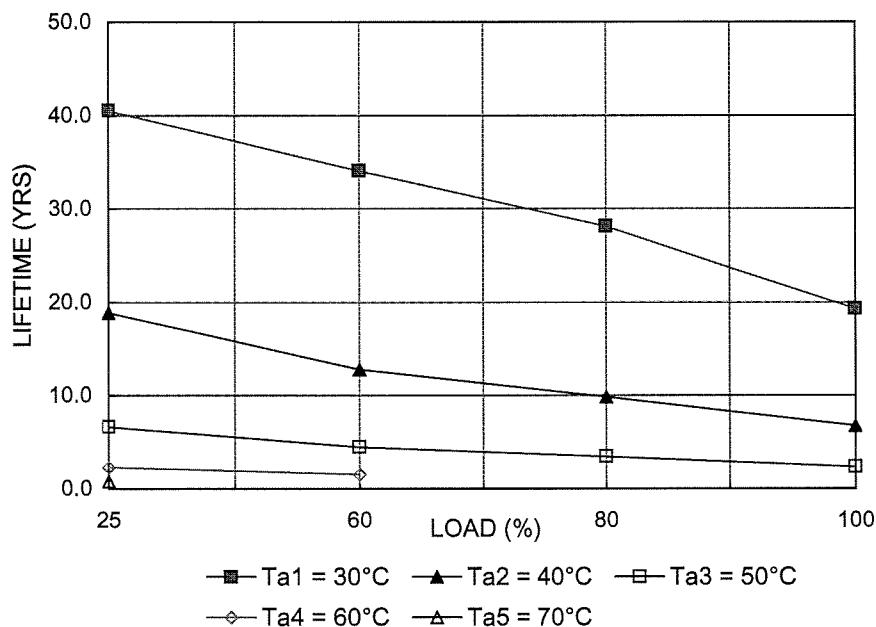
MOUNTING : B

VIN : 200VAC

DATE: SEPT 12, 2008

LOAD (%)	LIFETIME (YRS)				
	Ta = 30°C	Ta = 40°C	Ta = 50°C	Ta = 60°C	Ta = 70°C
25	40.5	18.9	6.6	2.3	0.8
60	34.1	12.8	4.5	1.6	
80	28.1	9.9	3.5		
100	19.3	6.8	2.4		

GRAPH OF ELECTROLYTIC CAPACITOR LIFETIME VS LOAD
MOUNTING B KWS5-5



計算式 FORMULA

- | | | |
|---|---------|--|
| 1. アルミ電解コンデンサ
AL. Electrolytic capacitor
$L = Lo \times 2^{(105-T_c)/10}$ | L : | 電解コンデンサ推定寿命計算値
Elec. Capacitor computed life.
(24時間連続稼動、365日)
(24 hrs per day, 365 days per year) |
| 2. OSコンデンサ
O.S capacitor
$L = Lo \times 10^{(105-T_c)/20}$ | Lo : | 電解コンデンサ保証寿命値
Guarantee life for Elec. cap. |
| | T_c : | 電解コンデンサのケース温度
Case temperature of Elec. cap. |

ELECTROLYTIC CAPACITOR LIFETIME VERSUS LOAD

MODEL : KWS5-5

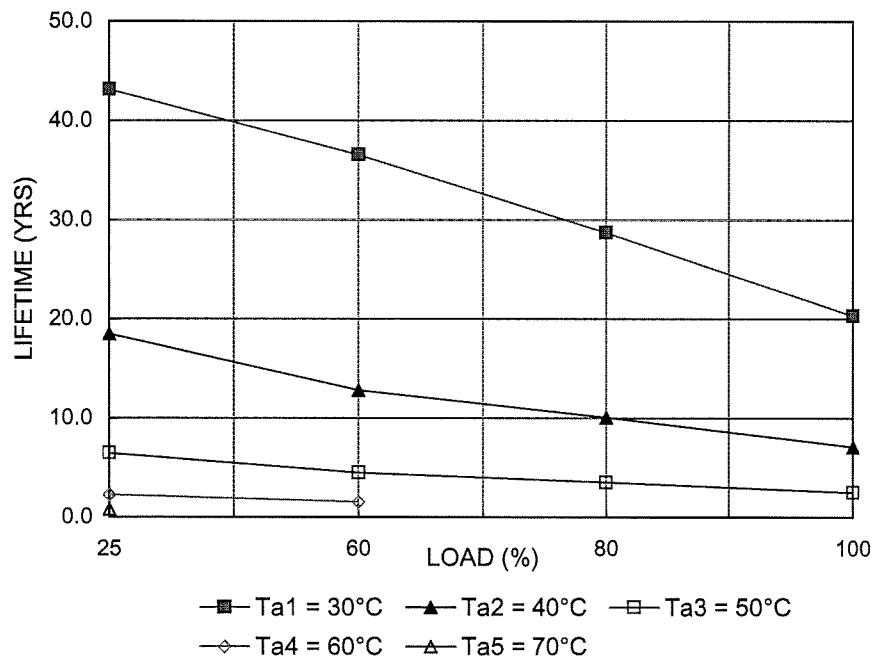
MOUNTING : C

VIN : 200VAC

DATE: SEPT 12, 2008

LOAD (%)	LIFETIME (YRS)				
	Ta = 30°C	Ta = 40°C	Ta = 50°C	Ta = 60°C	Ta = 70°C
25	43.1	18.5	6.5	2.3	0.8
60	36.6	12.8	4.5	1.6	
80	28.7	10.1	3.5		
100	20.3	7.1	2.5		

GRAPH OF ELECTROLYTIC CAPACITOR LIFETIME VS LOAD
MOUNTING C KWS5-5



計算式 FORMULA

- | | | |
|--|--------|--|
| 1. アルミ電解コンデンサ
AL. Electrolytic capacitor
$L = Lo \times 2^{(105-Tc)/10}$ | L : | 電解コンデンサ推定寿命計算値
Elec. Capacitor computed life.
(24時間連続稼動、365日)
(24 hrs per day, 365 days per year) |
| 2. OSコンデンサ
O.S capacitor
$L = Lo \times 10^{(105-Tc)/20}$ | Lo : | 電解コンデンサ保証寿命値
Guarantee life for Elec. cap. |
| | Tc : | 電解コンデンサのケース温度
Case temperature of Elec. cap. |

ELECTROLYTIC CAPACITOR LIFETIME VERSUS LOAD

MODEL : KWS5-5

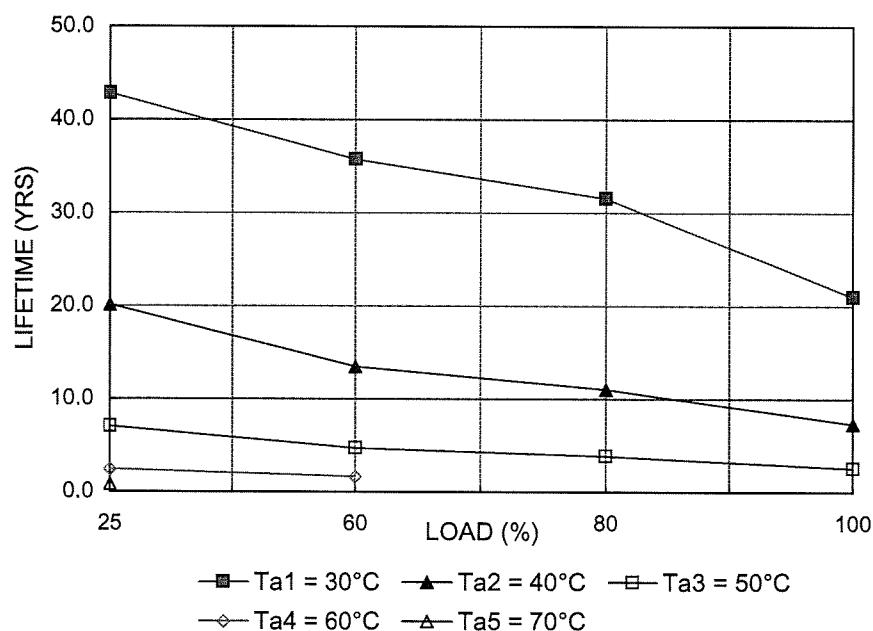
MOUNTING : D

VIN : 200VAC

DATE: SEPT 12, 2008

LOAD (%)	LIFETIME (YRS)				
	Ta = 30°C	Ta = 40°C	Ta = 50°C	Ta = 60°C	Ta = 70°C
25	42.8	20.1	7.1	2.5	0.9
60	35.8	13.5	4.8	1.7	
80	31.6	11.1	3.9		
100	21.0	7.4	2.6		

GRAPH OF ELECTROLYTIC CAPACITOR LIFETIME VS LOAD
MOUNTING D KWS5-5



計算式 FORMULA

1. アルミ電解コンデンサ
AL. Electrolytic capacitor
 $L = Lo \times 2^{(105-T_c)/10}$

L : 電解コンデンサ推定寿命計算値
Elec. Capacitor computed life.
(24 時間連続稼動、365 日)
(24 hrs per day, 365 days per year)

2. OSコンデンサ
O.S capacitor
 $L = Lo \times 10^{(105-T_c)/20}$

Lo : 電解コンデンサ保証寿命値
Guarantee life for Elec. cap.
Tc : 電解コンデンサのケース温度
Case temperature of Elec. cap.

ELECTROLYTIC CAPACITOR LIFETIME VERSUS LOAD

MODEL : KWS5-5

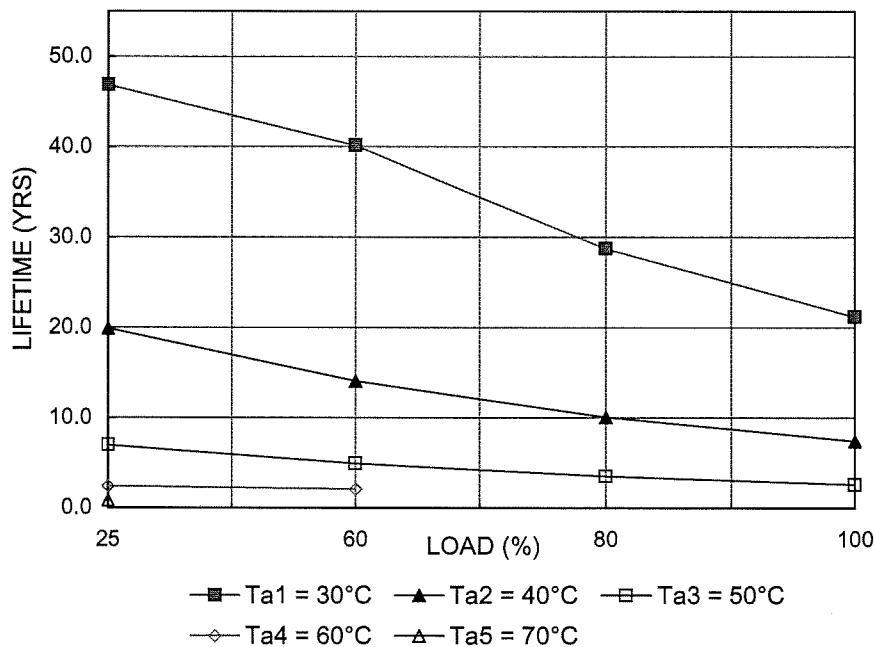
MOUNTING : E

VIN : 200VAC

DATE: SEPT 12, 2008

LOAD (%)	LIFETIME (YRS)				
	Ta = 30°C	Ta = 40°C	Ta = 50°C	Ta = 60°C	Ta = 70°C
25	46.9	19.9	7.0	2.5	0.9
60	40.2	14.1	5.0	2.1	
80	28.7	10.1	3.5		
100	21.2	7.5	2.6		

GRAPH OF ELECTROLYTIC CAPACITOR LIFETIME VS LOAD
MOUNTING E KWS5-5



計算式 FORMULA

1. アルミ電解コンデンサ
AL. Electrolytic capacitor

$$L = Lo \times 2^{(105-T_c)/10} \quad (\text{year})$$

L : 電解コンデンサ推定寿命計算値
Elec. Capacitor computed life.
(24時間連続稼動、365日)

(24 hrs per day, 365 days per year)

2. OSコンデンサ

O.S capacitor

$$L = Lo \times 10^{(105-T_c)/20} \quad (\text{year})$$

Lo : 電解コンデンサ保証寿命値
Guarantee life for Elec. cap.
Tc : 電解コンデンサのケース温度
Case temperature of Elec. cap.

DWG NO : PA766-57-02

APPROVED BY TESTED BY

WILLIAMS
2/14/93

MODEL : KWS5-5

TEST CONDITIONS

LOAD = 100 %

Vin = 200VAC

Ta = 25°C

ABNORMAL TESTING

TEST MODE

PARTS NAME	P A R T N O.	S O R T	H P E N	F I R E	S M R E	B U R S L	R D E	U M B A L	F U S C V	N O O 0	O C T H P P U	R E K T	N O G S T A E N R N R G S T E	NOTE	
1 UF1717H-103YR25-01	L1	*								*			*		*
2 UF1717H-103YR25-01	L1	*								*			*		*
3										*			*		
4 SIWB(A)60B	D1	AC	*							*			*		
5 SIWB(A)60B	D1	AC	*							*			*		
6 SIWB(A)60B	D1	DC	*							*			*		
7 SIWB(A)60B	D1	DC	*							*			*		
8															
9 ISS184TE85L	D2	A-K	*							*			*		
10 ISS184TE85L	D2	A-K	*							*			*		
11															
12 D1FL20U	D3	A-K	*							*			*		
13 D1FL20U	D3	A-K	*							*			*		
14															
15 EC8FS6	D4	A-K	*							*			*		
16 EC8FS6	D4	A-K	*							*			*		
17															
18 DE5SC4H	D5	A-K	*							*			*		
19 DE5SC4H	D5	A-K	*							*			*		
20															
21 1N4735A	ZD1	A-K	*							*			*		
22 1N4735A	ZD1	A-K	*							*			*		
23															
24															

*** a : slight b : prolonged

TDK-Lambda

DWG NO : PA766-57-04
 APPROVED BY TESTED BY
 WILLIAM
Signature 2/4/93

PARTS NAME	TEST MODE	TEST CONDITIONS											
		ABNORMAL TESTING			LOAD = 100 %			Viin = 200VAC			Ta = 25°C		
P A R T N O.		S H O R T	O P E N	F I R O E	S U R S L	B M E D T	R D A M L	U E B G O	U C V P W	N O O C T A H P N R G S	N O O C T A H P N R G S	R E K S T D	N O C T A H P N R G S
(a)	(b)												*
1 C55Y5U1E186Z-TE12	C6	*											*
2 C55Y5U1E186Z-TE12	C6	*											*
3													*
4 C2012X7R1E104KT	C7	*											*
5 C2012X7R1E104KT	C7	*											*
6													*
7 C3225C0G1H332J	C8	*											*
8 C3225C0G1H332J	C8	*											*
9													*
10 C2012C0G1H270KT	C9	*											*
11 C2012C0G1H270KT	C9	*											*
12													*
13 C2012C0G1H101KT	C10	*											*
14 C2012C0G1H101KT	C10	*											*
15													*
16 GR43-2W5R103K500PT	C11	*											*
17 GR43-2W5R103K500PT	C11	*											*
18													*
19 C2012X7R1H473KT	C12	*											*
20 C2012X7R1H473KT	C12	*											*
21													*
22 C25Y5U1E106Z	C13	*											*
23 C25Y5U1E106Z	C13	*											*
24													*

* : slight b : prolonged

TDK-Lambda

MODEL : KW55-5		ABNORMAL TESTING		TEST MODE		TEST CONDITIONS		LOAD = 100 %		Vin = 200VAC		Ta = 25°C		DWG NO : PA766-57-05		APPROVED BY		TESTED BY		
				P	A	S	T	R	M	B	S	R	F	U	N	R	E	T	N	
				R	T	H	I	O	E	M	U	D	E	S	O	G	E	S	O	
				T	N	O	R	E	K	A	E	A	S	L	T	A	T	N	G	
				N	O.	R	T	E	E	L	G	C	V	H	E	E	S	O	O	
										A	O	·	·	P	P	T	K	T	D	
										L	G	·	·	N	R	N	O	E	O	
										W	E	·	·	T	G	T	E	T	G	
										N	E	·	·	E	S	N	R	S	O	
										T	E	·	·	T	E	N	T	E	D	
												*	*	*	*	*	*	*	*	
1	10SA68M+H			C16		*														
2	10SA68M+H			C16		*														
3																				
4	C2012X7R1H473KT			C17		*														
5	C2012X7R1H473KT			C17		*														
6																				
7	DE7100F222MVAIN			C18		*														
8	DE7100F222MVAIN			C18		*														
9																				
10	C3216X7R1H154KT			C19		*														
11	C3216X7R1H154KT			C19		*														
12																				
13	CW21W5R102K200BT			C20		*														
14	CW21W5R102K200BT			C20		*														
15																				
16	ERJ8GEYJ514V			R1		*														
17	ERJ8GEYJ514V			R1		*														
18																				
19	ERJ8GEYJ514V			R2		*														
20	ERJ8GEYJ514V			R2		*														
21																				
22	ERJ8GEYJ514V			R3		*														
23	ERJ8GEYJ514V			R3		*														
24																				

*** a : slight b : prolonged

TDK-Lambda

MODEL : KWSS-5		ABNORMAL TESTING		TEST CONDITIONS		TEST		DWG NO : PA766-57-06	
				LOAD = 100 %		V _{in} = 200VAC		APPROVED BY	
				Ta = 25°C		William 2/10/93		TESTED BY	
PARTS	NAME	TEST MODE							
		P	S	F	B	F	N	R	N
		A	H	I	M	U	O	E	O
		R	O	R	R	E	O	T	G
		T	R	K	E	D	C	S	O
		N	T	E	T	A	V	H	T
		O.	.	(a)(b)	L	G	P	N	O
1	ERG1SJ623	R4	*		U	O	C	T	*
2	ERG1SJ623	R4	*		S	O	O	E	*
3					R	D	·	S	*
4	ERG1SJ623	R5	*		E	E	·	N	*
5	ERG1SJ623	R5	*		A	·	·	R	*
6					M	·	·	G	*
7	CR1/10W2001DV	R6	*		L	·	·	S	*
8	CR1/10W2001DV	R6	*		T	·	·	U	*
9					L	·	·	G	*
10	CR1/10W152JV	R7	*		H	·	·	T	*
11	CR1/10W152JV	R7	*		O	·	·	E	*
12					R	·	·	S	*
13	ERJ8GEYJ100V	R8	*		U	·	·	R	*
14	ERJ8GEYJ100V	R8	*		E	·	·	G	*
15					E	·	·	O	*
16	ERJ8GEYJ390V	R9	*		Y	·	·	T	*
17	ERJ8GEYJ390V	R9	*		J	·	·	S	*
18					J	·	·	S	*
19	CR1/10W222JV	R10	*		J	·	·	R	*
20	CR1/10W222JV	R10	*		J	·	·	G	*
21					J	·	·	O	*
22	CR1/10W331JV	R11	*		J	·	·	T	*
23	CR1/10W331JV	R11	*		J	·	·	S	*
24					J	·	·	S	*

*bright b : prolonged

TDK-Lambda

MODEL : KWS5-5

DWG NO : PA766-57-07
 APPROVED BY TESTED BY
 WILLIAM
 2/14/93 2/14/93

ABNORMAL TESTING

TEST CONDITIONS
 LOAD = 100 % Vin = 200VAC
 Ta = 25°C

TEST MODE

PARTS NAME	(a)(b)	TEST												NOTE	R E O T K S T D						
		P	A	R	T	S	O	H	P	I	M	B	S	U	D	E	C	N	O	R	N
1 CRI/10W183JV	R12	*															*			*	
2 CRI/10W183JV	R12	*															*			*	
3																					
4 ERJ8GEYJ7R5V	R13	*															*			*	
5 ERJ8GEYJ7R5V	R13	*															*			*	
6																					
7 ERJ8GEYJ7R5V	R14	*															*			*	
8 ERJ8GEYJ7R5V	R14	*															*			*	
9																					
10 ERJ8GEYJ8R2V	R15	*															*			*	
11 ERJ8GEYJ8R2V	R15	*															*			*	
12																					
13 ERJ8GEYJ270V	R17	*															*			*	
14 ERJ8GEYJ270V	R17	*															*			*	
15																					
16 ERJ8GEYJ270V	R18	*															*			*	
17 ERJ8GEYJ270V	R18	*															*			*	
18																					
19 ERJ8GEYJ823V	R19	*															*			*	
20 ERJ8GEYJ823V	R19	*															*			*	
21																					
22 ERJ8GEYJ823V	R20	*															*			*	
23 ERJ8GEYJ823V	R20	*															*			*	
24																					

*** : slight b : prolonged

TDK-Lambda

21
32

MODEL :	KWS5-5	TEST MODE		TEST CONDITIONS		APPROVED BY		TESTED BY	
		ABNORMAL	TESTING	LOAD = 100 %	V _{in} = 200VAC	T _a = 25°C	WILLIAM 2/4/93	DK 2/4/93	R E O T S G D
		P A R T N 0.	S H O R T	F I R E	B U R S L T	F U D E U S	N O O C T H H	O K T P N R S T E	
									*
1	ERJ8GEVJ823V	R21	*						*
2	ERJ8GEVJ823V	R21	*						*
3									
4	ERJ8GEVJ823V	R22	*						*
5	ERJ8GEVJ823V	R22	*						*
6									
7	ERJ8GEVJ150V	R23	*						*
8	ERJ8GEVJ150V	R23	*						*
9									
10	ERJ8GEVJ150V	R24	*						*
11	ERJ8GEVJ150V	R24	*						*
12									
13	ERJ8GEVJ150V	R25	*						*
14	ERJ8GEVJ150V	R25	*						*
15									
16	ERJ8GEVJ150V	R26	*						*
17	ERJ8GEVJ150V	R26	*						*
18									
19	ERJ8GEVJ241V	R27	*						*
20	ERJ8GEVJ241V	R27	*						*
21									
22	ERJ8GEVJ241V	R28	*						*
23	ERJ8GEVJ241V	R28	*						*
24									

*** a : slight b : prolonged

TDK-Lambda

*** a : slight b : prolonged

MODEL : KWS5-5		TEST MODE		TEST CONDITIONS		TEST		TESTED BY	
		ABNORMAL TESTING		LOAD = 100 %		V _{in} = 200VAC		APPROVED BY	
				Ta = 25°C		T _a = 25°C		WILLIAM JAN 1993	
PARTS	NAME	S	O	F	S	B	R	D	U
A	R	H	P	I	M	U	E	E	S
T	N	O	R	O	R	R	D	A	E
N	0.	T	T	E	K	S	L	M	H
(a)	(b)								
1	ERJ8GEYJ241V	R29	*						*
2	ERJ8GEYJ241V	R29	*						*
3									
4	CR1/10W2001DV	R30	*					*	*
5	CR1/10W2001DV	R30	*					*	*
6									
7	CR1/10W2051DV	R31	*					*	*
8	CR1/10W2051DV	R31	*					*	*
9									
10	CR1/10W7681DV	R32	*					*	*
11	CR1/10W7681DV	R32	*					*	*
12									
13	CR1/10W222JV	R33	*					*	*
14	CR1/10W222JV	R33	*					*	*
15									
16	ERJ8GEYJ511V	R34	*					*	*
17	ERJ8GEYJ511V	R34	*					*	*
18									
19									
20									
21									
22									
23									
24									

NOTE
F U N N O R E S T G
U S O O C T E S O
S D E O O C T E S O
R E A C V T E S O
B M B C P T E S O
D M A L P P T E S O
E R G O P P T E S O
H L O W U G T E S O
G O E W U G T E S O
L T O N T E S O
A T E N T E S O
R H A E S O
E S T E S O
S O T E S O
T E S O
D E S O
*

MODEL : KW55-5		ABNORMAL TESTING		TEST MODE		TEST CONDITIONS		LOAD = 100 %		TEST CONDITIONS		APPROVED BY		TESTED BY		
								Vin = 200VAC		Ta = 25°C						
P	A	S	H	B	S	R	D	U	N	O	C	T	R	N	*	
A	R	H	P	M	E	E	A	M	O	O	U	H	E	G	*	
T	T	O	E	R	R	E	D	A	T	C	T	A	K	S	*	
N	O.	R	T	K	S	L	G	L	R	P	N	G	T	O	*	
				E	E	T	W	O	S	U	G	E	D			
								T	N	T	E					
(a)	(b)															
1	TLP121GR (DIODE)	PCI	1-3	*												*
2	TLP121GR (DIODE)	PCI	1-3	*												*
3	TLP121GR (TRANS)	PCI	4-6	*												*
4	TLP121GR (TRANS)	PCI	4-6	*												*
5																
6	HA17431FPA-TR	A2	A-K	*												*
7	HA17431FPA-TR	A2	REF-A	*												*
8																
9	2SK1533-4100	Q1	D-S	*												*
10	2SK1533-4100	Q1	G-S	*												*
11																
12	MKC-S683M	C1	*													*
13	MKC-S683M	C1	*													*
14																
15	PME290MA4330M	C3	*													*
16	PME290MA4330M	C3	*													*
17																
18	PME290MA4330M	C4	*													*
19	PME290MA4330M	C4	*													*
20																
21	LXA400VBSN-27(M)	C5	*													*
22	LXA400VBSN-27(M)	C5	*													*
23																
24																

*** a : slight b : prolonged

TDK-Lambda

振動試験 VIBRATION TEST

MODEL : KWS5-12

(1) 振動試験種類 Vibration test class

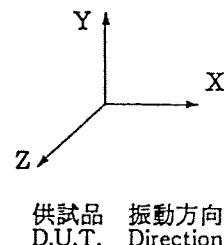
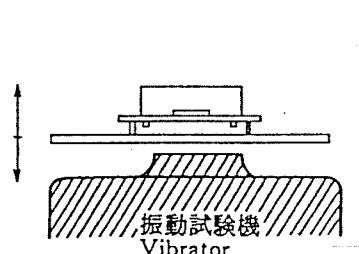
掃引振動数耐久試験 Frequency variable endurance test

(2) 使用振動試験装置 Equipment used

新日本測器錫製 制御部 F-400-BM-E47

SHIN-NIPPON Controller
SOKKI Co., LTD加振部 905-FN
Vibrator

(3) 試験方法 Testing method



可変周波数振動試験

- ・周波数範囲 10~55Hz
Sweep frequency
- ・掃引時間 1分間
Sweep time 1 min.
- ・振幅 一定 (1.65mm)
Amplitude const.
- ・振幅方向 X, Y, Z.
Direction
- ・試験時間 各方向共 1 H
Test time 1H each

(4) 試験結果 Result

合格
OK

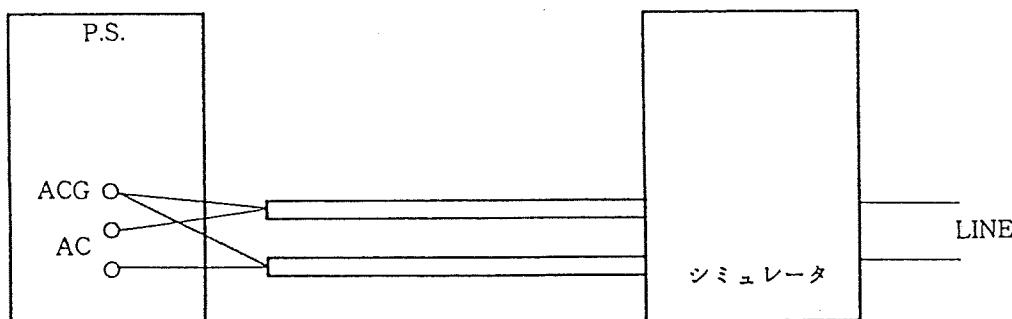
不合格
NG

測定確認項目 Check item	出力電圧 (V) Vout	リップル (mVp-p) Ripple (mVp-p)	機能・実装状態 D. U. T. state	備考 Note
試験前 Initial 振動方向 Directions	11.98	75.5	異常なし OK	
X	11.98	75.5	異常なし OK	
Y	11.98	75.5	異常なし OK	
Z	11.98	75.0	異常なし OK	

ノイズシミュレート試験 NOISE SIMULATE TEST

MODEL : KWS5

(1) 測定回路及び測定機 Test circuit and equipment

シミュレータ : ENS-24X (三基電子工業㈱)
(SANKI E. IND)

(2) 測定条件 Measuring Conditions

- ・入力電圧: 定格
Input voltage Rated
- ・出力電圧: 定格
Output voltage Rated
- ・出力電流: 0%, 100%
Output Current
- ・電源周囲温度: 25°C
Ambient temperature
- ・パルス幅: 50ns~1000ns
Pulse width
- ・ノイズ電圧: 0 ~ 2 kV
Noise level
- ・位相: 0 ~ 360°
Phase shift
- ・極性: +, -
Polarity
- ・MODE : NORMAL, COMMON
- ・TRIG SELECT : LINE

(3) 判定条件 Acceptable conditions

1. 破壊しない事 Not to be broken
2. 出力がダウンしない事 Not to be shut down output
3. その他異常のない事 No other out of orders

(4) 試験結果 Results

合格
 OK

不合格
N G

静電気シミュレーション試験

ELECTRO-STATIC DISCHARGE TEST

MODEL : KWS5

(1) 使用計測器 Equipment used

SET-30E (三基電子工業(株))

(SANKI. E. IND.)

放電抵抗: 250Ω 静電容量: 200pF

Discharge resistance Capacity

(2) 測定条件 Measuring conditions

・入力電圧: 定格 ・出力電圧: 定格 ・出力電流: 定格

Input voltage : Rated Output voltage : Rated Output current : Rated

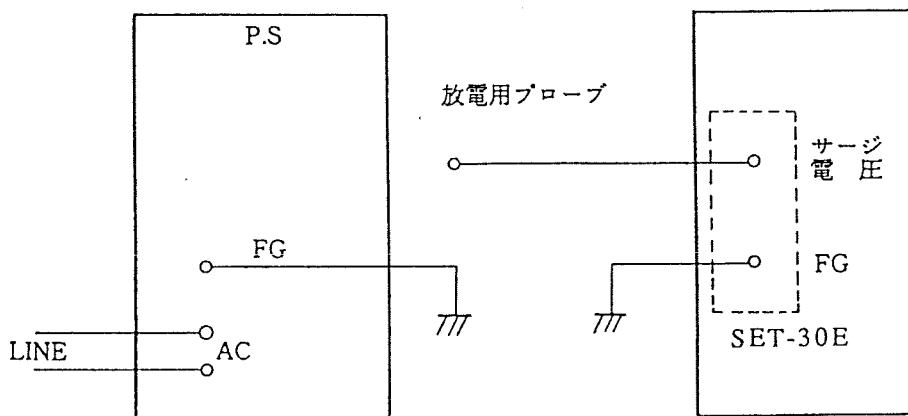
・電源周囲温度: 25°C ・印加電圧: ±3KV, ±5KV, ±10KV, ±15KV

Ambient temperature Test voltage

(3) 試験方法 Testing method

被試験電源を稼働状態にしておき、露出部分で人体がふれる可能性のある部分（ケース、入力端子、出力端子、FG端子、ACG端子）に放電をさせ、出力に異常の無い事を確認する。

尚、試験回数は、+、-各3回とし、引加電圧は3KVから15KVまで順次上げていくものとする。Check if there is no abnormal output when the testing voltage is applied to operating D. U. T. (Device Under Test) on its case, input terminal, output terminal, FG terminal and ACG terminal which are exposed parts to human body. Testing cycle is at +, - for three times each, and the applied voltage to be gradually increased from 3KV to 15KV.



(4) 判定条件 Acceptable conditions

1. 破壊しない事 Not to be broken
2. 出力電圧がダウンしない事 Not to be shut down output
3. その他異常の無いこと No other out of orders

(5) 試験結果 Result

合格

不合格

OK

N G

雷サージ試験 IMPULSE TEST

MODEL : KWS5

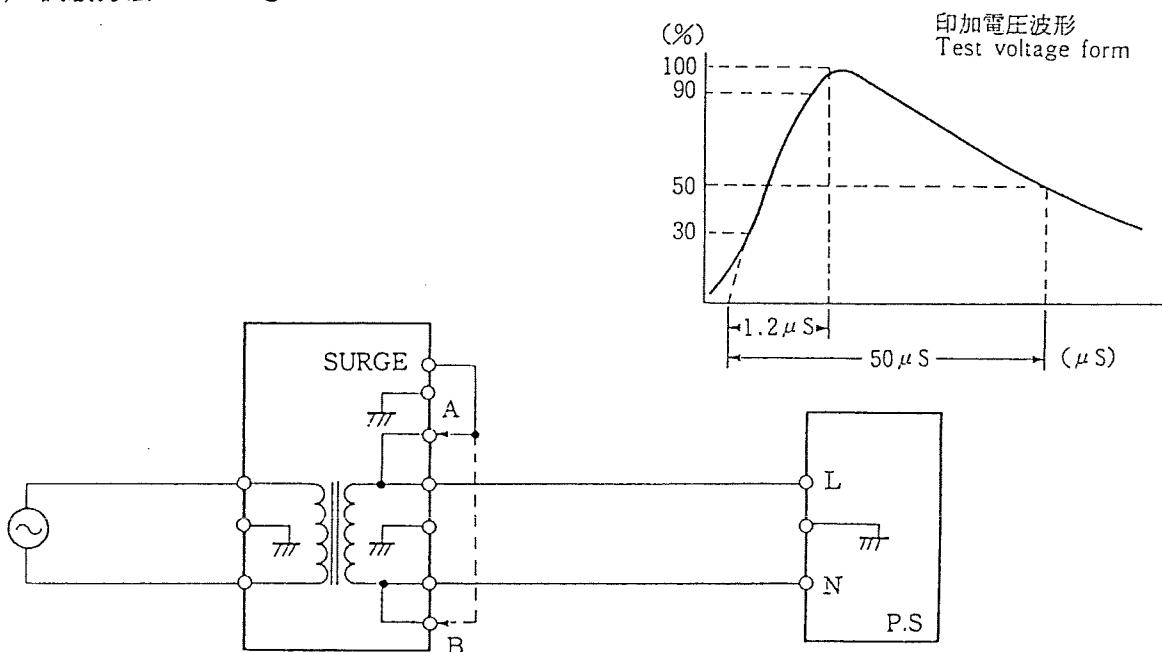
(1) 使用計測器 Equipment used

LSG-12K-E (三基電子工業(株))
(SANKI. E. IND.)

(2) 測定条件 Measuring conditions

- | | |
|--|--|
| ・入力電圧: 定格
Input voltage : Rated | ・印加電圧: 5kV
Test voltage |
| ・出力電圧: 定格
Output voltage : Rated | ・印加箇所: FG-AC 間
Test point : Between FG-AC |
| ・出力電流: 無負荷
Output current : No load | ・試験回数: 3回
Test time : 3 times |
| ・電源周囲温度: 25°C
Ambient temperature | ・極性: +, -
Polarity |

(3) 試験方法 Testing method



(4) 判定条件 Acceptable conditions

1. 破壊しない事 Not to be broken
2. 出力電圧がダウンしない事 Not to be shut down output
3. その他異常の無いこと No other out of orders

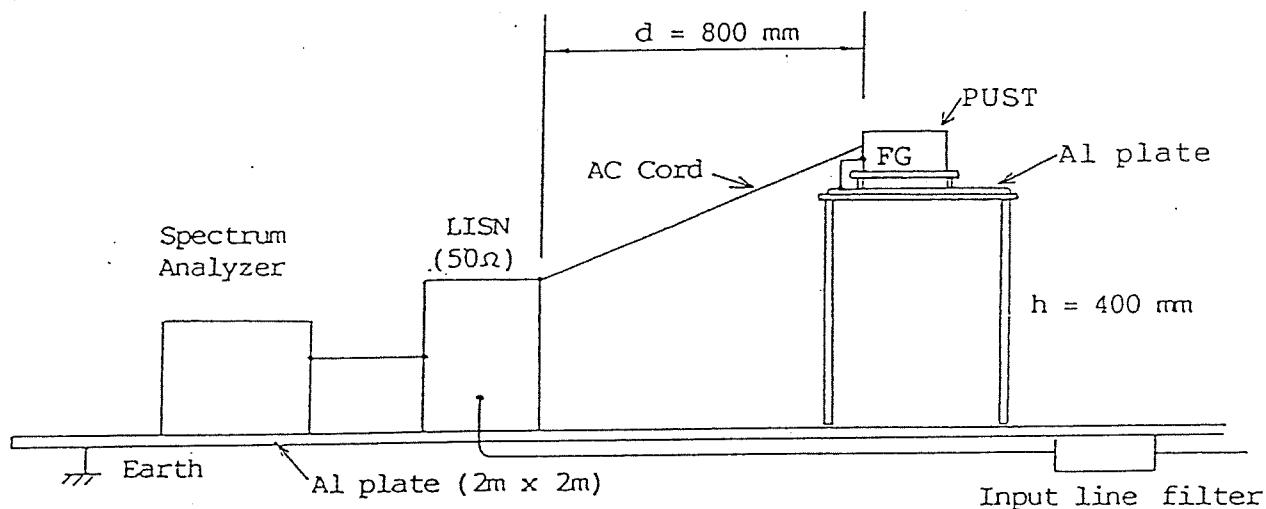
(5) 試験結果 Result

合格
 OK

不合格
N G

EMI TEST

TEST CIRCUIT :



TEST EQUIPMENTS :

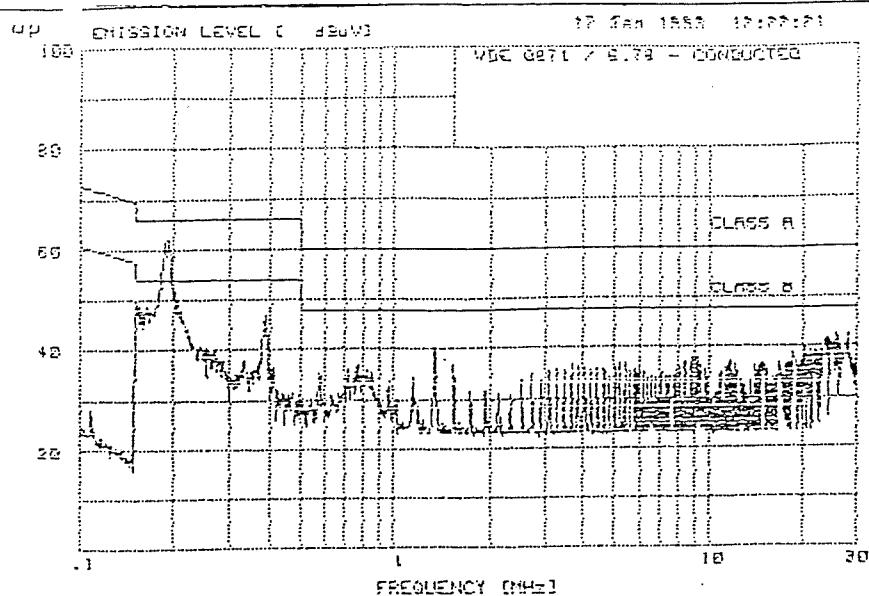
SPECTRUM ANALYZER	8568B	HEWLETT PACKARD
QUASI-PEAK ADAPTER	85650A	HEWLETT PACKARD
RF PRESELECTOR	85685A	HEWLETT PACKARD
LISN	3825/2	EHCO

CONDITIONS :

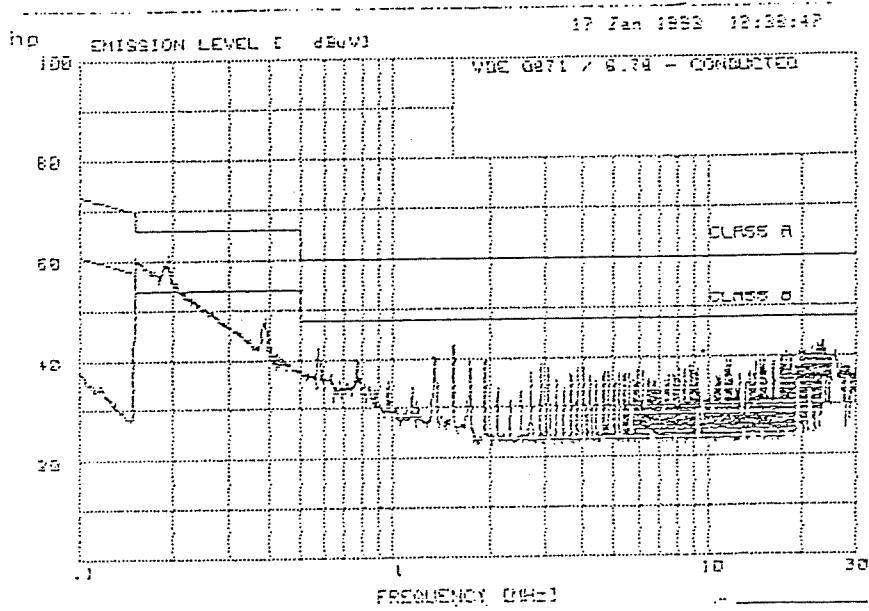
INPUT VOLTAGE	:	AC100V, AC200V
OUTPUT VOLTAGE	:	RATED
OUTPUT CURRENT	:	RATED
AMBIENT TEMP.	:	25°C

認 APPD		設計 ENGR	-	図面番号 D WG-No. PA766-71-02-
検 CHK		製 DWG	-	

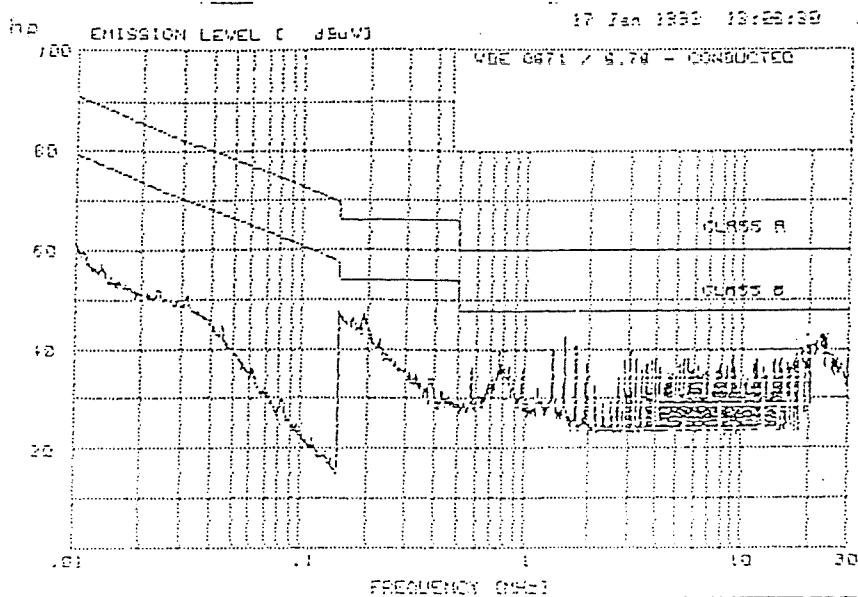
DATE 2.FEB.1993.



Vin = 100Vac



Vin = 200Vac



Vin = 200Vac

V D E

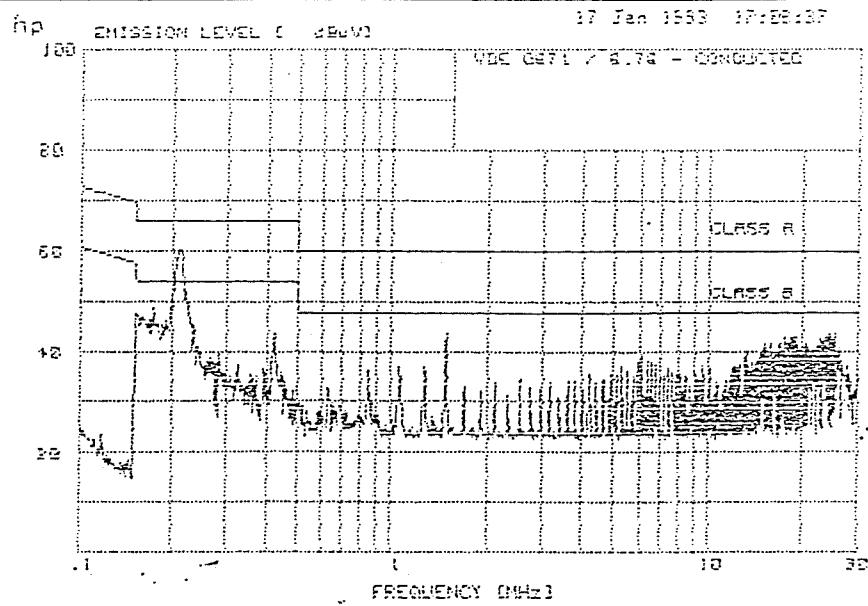
with external cap.
0.22μF between
Ac(L) and Ac(N)

認 APPD	.	設 計 ENGR	.	図面番号 D W G - N o .
検 C H K	.	製 図 D W G	.	PA766-71-03 -

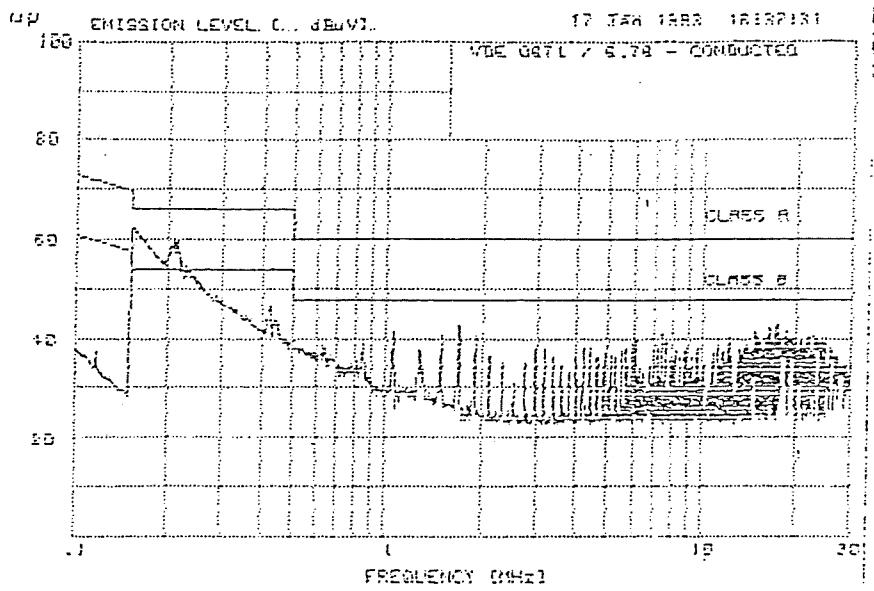
KWS5-12

DATE

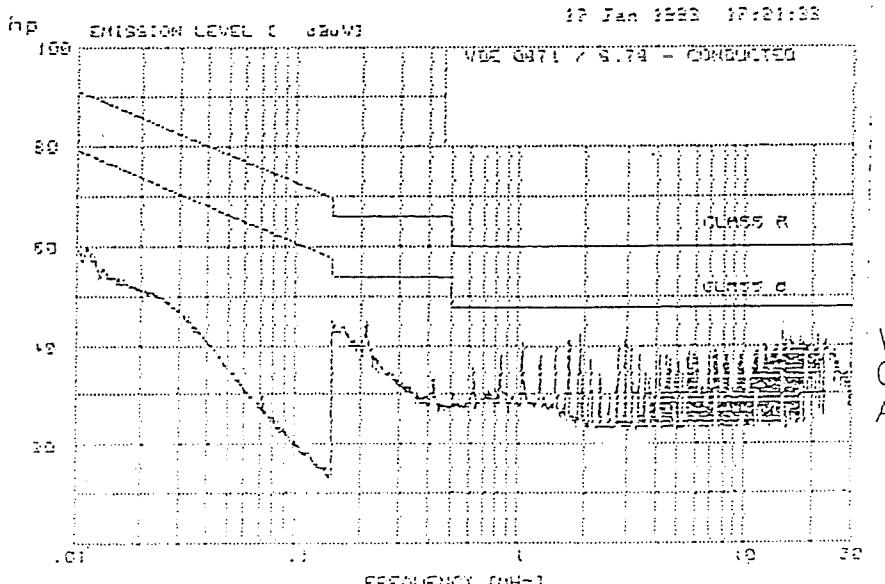
2.FEB.1993.



Vin = 100Vac



Vin = 200Vac



Vin = 200Vac

V D E

With external cap.
0.22μF between
Ac(L) and Ac(N).

認 APPD		設 計 ENGR	図面番号 D WG - No.
検 C H K		製 D W G	PA766-71-04- []

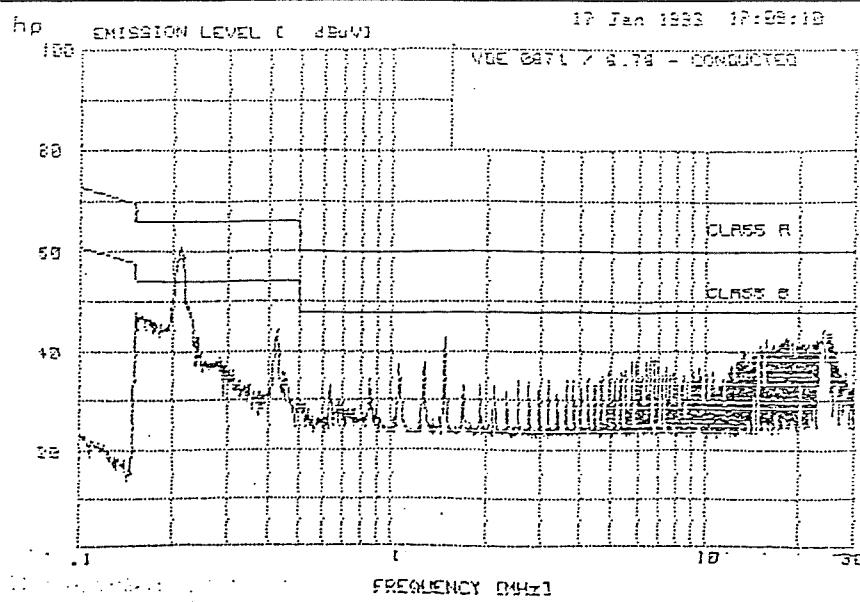
TDK-Lambda

KWS5-15

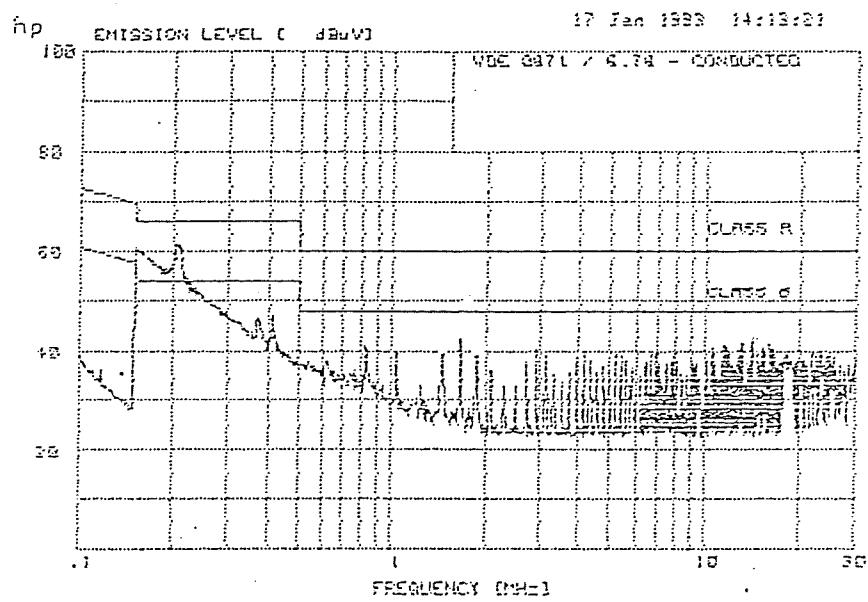
32
32

DATE

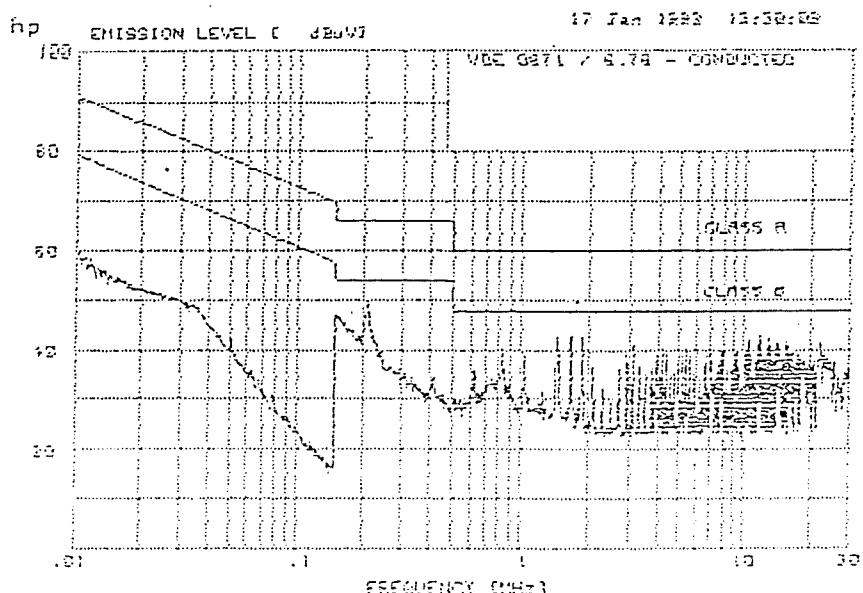
2.FEB.1993.



Vin = 100Vac



Vin = 200Vac



Vin = 20CVac

V D E

With external cap.
0.22μF between
Ac(L) and Ac(N).

認 APPD	.	設計 ENGR	.	図面番号 DWG-No.
検 C H K	.	製 DWG	.	PA766-71-05-

TDK-Lambda